## Notice of References Cited Application/Control No. 10/791,265 Examiner Pavitra Kotini Applicant(s)/Patent Under Reexamination PARASCHAC ET AL. Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-3,708,883 A	01-1973	Flander, Stanley	433/174
*	В	US-5,236,445 A	08-1993	Hayhurst et al.	606/232
*	С	US-5,480,403 A	01-1996	Lee et al.	606/72
*	D	US-5,571,104 A	11-1996	Li, Lehmann K.	606/72
*	E	US-5,634,936 A	06-1997	Linden et al.	606/213
*	F	US-5,893,856 A	04-1999	Jacob et al.	606/151
*	G	US-6,368,341 B1	04-2002	Abrahamson, Timothy Alan	606/213
*	н	US-2002/0082622 A1	06-2002	Kane, David Lee	606/151
*	ı	US-2002/0072768 A1	06-2002	Ginn, Richard S.	606/213
*	J	US-6,562,071 B2	05-2003	Jarvinen, Teppo	623/13.14
	К	US-			
	L	US-		·	
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	s					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
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